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Determination of Defect Distribution in a Ga-rich ZnO/CdS/Cu(In,Ga)Se<sub>2</sub> Solar Cell by Admittance Spectroscopy

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Keywords Authors Abstract: This article presents a study on the energy distribution of defects in efficient thin film ZnO/CdS/Cu(In,Ga)Se<sub>2</sub> heterojunction solar cell by the use of admittance spectroscopy. The capacitance spectra of the device has been analyzed using a model based on the existence of a homogeneous distribution of bulk acceptors in the absorber Cu(In,Ga)Se<sub>2</sub> layer. This model reveals an emission from a distribution of hole traps centered at an activation energy of about 300 meV with a defect density of 1.2 \times 10<sup>17</sup> eV<sup>-1</sup> cm<sup>-3</sup>. The band gap of the absorber layer is estimated to be about 1.46 eV which corresponds to a Ga content of about x \approx 0.7 with x the ratio Ga/(Ga+In).



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